Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,494	CHOI ET AL.
Examiner	Art Unit
Suk Jin Kang	2616

SEARCHED			
Class	Subclass	Date	Examiner
370	498	6/27/2007	SJK
370	420	6/27/2007	SJK
370	421	6/27/2007	SJK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	6/27/2007	SJK
Inventor name and Assignee search in PALM ExPO and EAST	6/27/2007	SJK
Consulted with Chau Nguyen (SPE)	6/27/2007	SJK
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